Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/807,425	SASAKI ET AL.		
Examiner	Art Unit		
Paul D. Kim	3729		

SEARCHED					
Class	Subclass	Date	Examiner		
29	603.07 603.12 603.15 603.16 603.18	1/23/2006	PK		
360	235.1- 235•3				
	235.7 235. B				
	236.1 236•3				
	246.2				
451	4,51				
216	65				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Reviewed Parent Application 10/041,566 (US PAT. 6,731,464,)	1/23/2006	PK	
Text Search EAST/NPL (IEEE)	1/23/2006	PK	